IN THE CLAIMS:

Please cancel claims 1-2 and 5-6 without prejudice or disclaimer to the subject matter recited therein.

- 3. (Original) A semiconductor device, comprising:
- a clock input terminal to which external clocks are supplied;
- a PLL circuit, which is supplied with the external clocks and generate first internal clocks;
 - a logic circuit, which operates in synchronization with the internal clocks;
- a test clock terminal to which test clocks are supplied from an external circuit, the test clock having a frequency with a predetermined phase difference from the external clocks;
- a flip-flop circuit, which is supplied with the test clocks and the first internal clocks to generate second internal clocks; and an internal counter, which counts the second internal clocks when the PLL circuit is tested.

wherein

the internal counter is provided with an output terminal from which an output signal thereof is supplied to an external circuit.

- 4. (Original) A semiconductor device according to claim 3, further comprising:
- a second logic gate, which is supplied with the second internal clocks and the test clocks; and
- a reset terminal to which a reset signal is supplied from an external circuit to the counter, wherein
- the counter operates in accordance with an output signal of the second logic gate and the reset signal.